

4NM65-U2

Power MOSFET

4A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

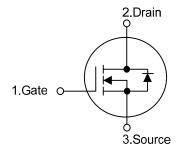
DESCRIPTION

The UTC **4NM65-U2** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications at power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)}$ < 2.1 Ω @ V_{GS} =10V, I_D = 2.0 A
- * Fast Switching Capability
- * Improved dv/dt Capability, High Ruggedness

SYMBOL



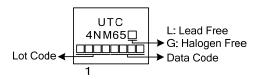
ORDERING INFORMATION

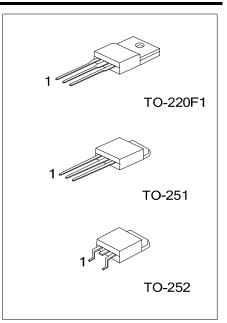
Ordering Number		Deekege	Pin Assignment			Deaking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
4NM65L-TF1-T	4NM65G-TF1-T	TO-220F1	G	D	S	Tube	
4NM65L-TM3-T	4NM65G-TM3-T	TO-251	G	D	S	Tube	
4NM65L-TN3-R	4NM65G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source

4NM65G-TF1-T (1)Packing Type	(1) T: Tube, R: Tape Reel
(2)Package Type	(2) TF1: TO-220F1, TM3: TO-251, TN3: TO-252
(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

MARKING





■ ABSOLUTE MAXIMUM RATINGS (T_c = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	650	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Current	Continuous	I _D	4	А
Drain Current	Pulsed (Note 2)	I _{DM}	16	А
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	116	mJ
Peak Diode Recovery dv/dt (No	ote 4)	dv/dt	4	V/ns
Dower Dissinction	TO-220F1	D	36	W
Power Dissipation	TO-251/TO-252	PD	50	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=144mH, I_{AS} =1.27A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25°C

4. $I_{SD} \le 4.0A$, $di/dt \le 200A/\mu s$, $V_{DD} \le 6V_y$, $I_{G} = 2.5 \Omega_y$, $Starting T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT	
lupation to Ambient	TO-220F1	0	62.5	°C/W	
Junction to Ambient	TO-251/TO-252	θ _{JA}	110	°C/W	
lunction to Coop	TO-220F1	θ _{JC}	3.67	°C/W	
Junction to Case	TO-251/TO-252		2.5	°C/W	



4NM65-U2

■ ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

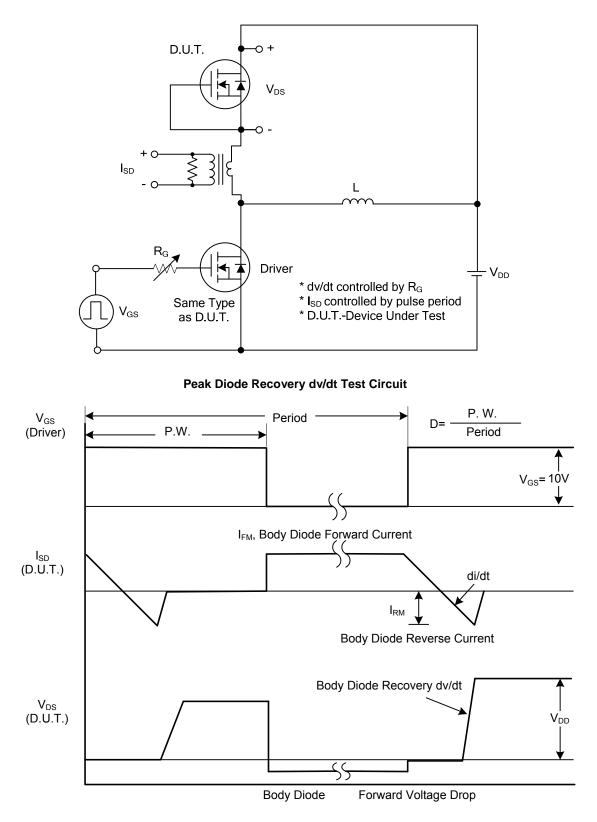
SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV _{DSS}	V _{GS} =0V, Ι _D =250μΑ	650			V
I _{DSS}	V _{DS} =650V, V _{GS} =0V			10	μA
orward	V _{GS} =30V, V _{DS} =0V			100	nA
IGSS	V _{GS} =-30V, V _{DS} =0V			-100	ΠA
V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250µA	2.5		4.5	V
R _{DS(ON)}	V _{GS} =10V, I _D =2.0A			2.1	Ω
C _{ISS}			220		рF
Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		170		рF
C _{RSS}			16		рF
Q_{G}			16.5		nC
Q_{GS}			5.4		nC
Q_{GD}	$-I_D$ =4.0A, I_G =5mA (Note 1, 2)		6.4		nC
t _{D(ON)}			7.2		ns
t _R	V _{DD} =200V, V _{GS} =10V,		16.5		ns
t _{D(OFF)}	_{F)} I _D =4.0A, R _G =25Ω (Note 1, 2)		32		ns
t _F			28		ns
ARACTERIST	ICS				
Is				4.0	Α
I _{SM}				20	Α
V _{SD}	I _S =4.0A, V _{GS} =0V			1.4	V
t _{rr}	I _S =4.0A, V _{GS} =0V,		260		ns
Q _{rr}	dI _F /dt=100A/µs		1.76		μC
	BV _{DSS} I _{DSS} I _{GSS} V _{GS(TH)} R _{DS(ON)} C _{ISS} C _{OSS} C _{RSS} Q _G Q _{GS} Q _{GD} t _{D(OFF)} t _F ARACTERIST I _S I _{SM} V _{SD} t _r	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$

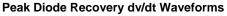
Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

2. Essentially independent of operating temperature.



TEST CIRCUITS AND WAVEFORMS

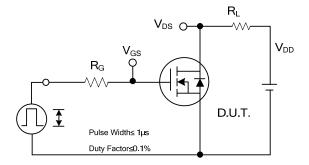




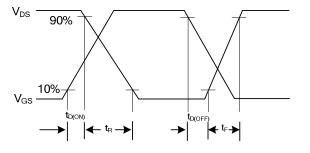


4NM65-U2

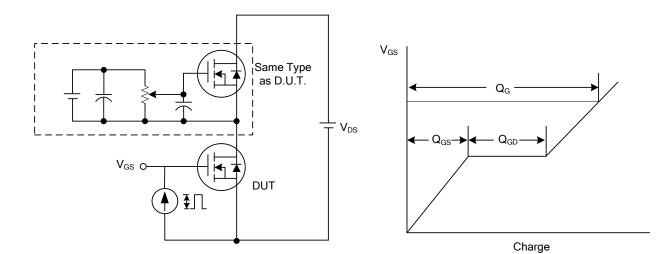
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



Switching Test Circuit

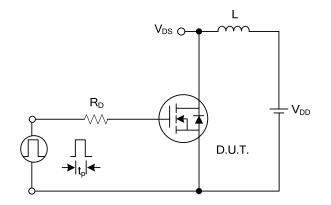


Switching Waveforms



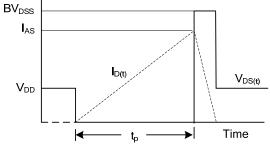
Gate Charge Test Circuit

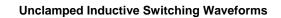
Gate Charge Waveform



Unclamped Inductive Switching Test Circuit

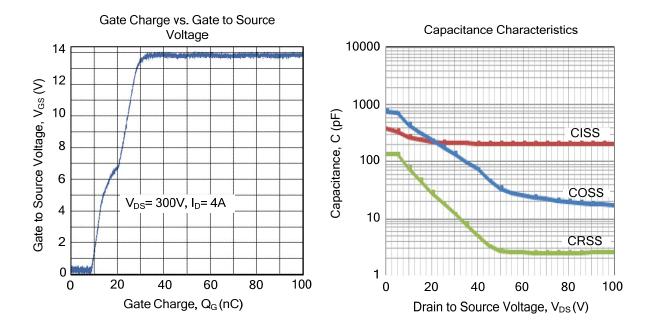








TYPICAL CHARACTERISTICS



UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.

